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| Notice of References Cited | Application/Control No. 10/700,353 | | Applicant(s)/Patent Under Reexamination DAIDONE ET AL. | |
| | Examiner ALAN LIU | | Art Unit 3691 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------------|----------------|
| * | A | US-5,822,414 A | 10-1998 | Reding et al. | 379/114.04 |
| * | B | US-6,032,132 A | 02-2000 | Nelson, Nickolas B. | 705/34 |
| * | C | US-6,240,167 B1 | 05-2001 | Michaels, Raymond Joseph | 379/106.03 |
| * | D | US-2002/0082991 A1 | 06-2002 | Friedman et al. | 705/40 |
| * | E | US-2002/0129039 A1 | 09-2002 | Majewski et al. | 707/200 |
| * | F | US-2003/0036918 A1 | 02-2003 | Pintsov, Leon A. | 705/1 |
| * | G | US-2004/0081302 A1 | 04-2004 | Kim et al. | 379/114.22 |
| * | H | US-6,975,208 B2 | 12-2005 | Zai, Xinyu | 340/309.16 |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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